Add A Page Defete Last Fage		
	Application/Control No.	Applicant(s)/Patent Under
	00/740 040	Reexamination

lotice of References Cited	09/740,040 Reexamination ZOMBEK ET AL.			
Notice of Neierences Ched	Examiner	Art Unit		
	AVI GOLD	2457	Page 1 of 1	

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-6,778,099 B1	08-2004	Meyer et al.	340/870.02
*	В	US-6,721,779 B1	04-2004	Maffeis, Silvano	709/202
*	С	US-6,304,564 B1	10-2001	Monin et al.	370/338
*	D	US-6,718,384 B2	04-2004	Linzy, Richard J.	709/224
*	Е	US-6,628,965 B1	09-2003	LaRosa et al.	455/557
*	F	US-5,446,736	08-1995	Gleeson et al.	370/473
*	G	US-5,970,059	10-1999	Ahopelto et al.	370/338
*	Н	US-5,673,322	09-1997	Pepe et al.	705/52
*	1	US-6,874,018	03-2005	Wu, Handong	709/219
*	J	US-6,721,872	04-2004	Dunlop et al.	712/28
*	к	US-6,785,261	08-2004	Schuster et al.	370/352
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Auto-Fill